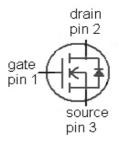


OptiMOS(TM)3 Power-Transistor

Features

- Ideal for high frequency switching and sync. rec.
- Optimized technology for DC/DC converters
- Excellent gate charge x R DS(on) product (FOM)
- Very low on-resistance $R_{DS(on)}$
- N-channel, logic level
- 100% avalanche tested
- Pb-free plating; RoHS compliant
- Qualified according to JEDEC¹⁾ for target applications

Туре	IPD031N06L3 G
	2 (tab)
Package	PG-TO-252-3
Marking	031N06L



Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	T _C =25 °C ²⁾	100	А
		T _C =100 °C	100]
Pulsed drain current ³⁾	/ _{D,pulse}	T _C =25 °C	400	
Avalanche energy, single pulse ⁴⁾	E _{AS}	$I_{\rm D}$ =100 A, $R_{\rm GS}$ =25 Ω	149	mJ
Gate source voltage	V _{GS}		±20	V
Power dissipation	P _{tot}	T _C =25 °C	167	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

¹⁾J-STD20 and JESD22

Product Summary

V _{DS}	60	٧
R _{DS(on),max}	3.1	mΩ
I _D	100	Α



 $^{^{2)}}$ Current is limited by bondwire; with an $R_{\rm thJC}$ =0.9 K/W the chip is able to carry 172 A.

 $^{^{3)}}$ See figure 3 for more detailed information

⁴⁾ See figure 13 for more detailed information



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R _{thJC}		-	-	0.9	K/W
Thermal resistance,	R_{thJA}	minimal footprint	-	-	62	
junction - ambient		6 cm² cooling area ⁵⁾	-	-	40	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =1 mA	60	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 93 \mu {\rm A}$	1.2	1.7	2.2	
Zero gate voltage drain current	I _{DSS}	$V_{\rm DS}$ =60 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C	1	0.1	1	μΑ
		V _{DS} =60 V, V _{GS} =0 V, T _j =125 °C	-	10	100	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	1	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =100 A	-	2.5	3.1	mΩ
		V _{GS} =4.5 V, I _D =50 A	1	3.5	5.2	
Gate resistance	R _G		-	1.3	-	Ω
Transconductance	$g_{ ext{fs}}$	V _{DS} >2 I _D R _{DS(on)max} , I _D =100 A	83	165	-	s

 $^{^{5)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.



Parameter	Symbol	symbol Conditions		Values		
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C iss		-	10000	13000	pF
Output capacitance	C _{oss}	V_{GS} =0 V, V_{DS} =30 V, f=1 MHz	-	1700	2300	
Reverse transfer capacitance	C _{rss}		-	70	-	
Turn-on delay time	t _{d(on)}		-	25	-	ns
Rise time	t _r	V _{DD} =30 V, V _{GS} =10 V,	-	78	-	
Turn-off delay time	$t_{\text{d(off)}}$	/ _D =90 A, R _G =1.6 Ω	-	64	-	
Fall time	t _f	1	-	13	-	1
Gate Charge Characteristics ⁶⁾			Γ	1	.	
Gate to source charge	Q _{gs}		-	34	-	nC
Gate to drain charge	Q_{gd}	V _{DD} =30 V, / _D =100 A, V _{GS} =0 to 4.5 V	-	11	-]
Switching charge	Q_{sw}		-	29	-]
Gate charge total	Qg		-	59	79	
Gate plateau voltage	V _{plateau}		-	3.5	-	٧
Output charge	Q oss	V _{DD} =30 V, V _{GS} =0 V	-	83	110	nC
Reverse Diode	-					
Diode continous forward current	Is	T _C =25 °C	-	-	100	А
Diode pulse current	/ _{S,pulse}	7 c-25 C	-	-	400	
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =100 A, T _j =25 °C	-	0.9	1.2	V
Reverse recovery time	t rr	V _R =30 V, / _F =90A,	-	44	-	ns
Reverse recovery charge	Q _{rr}	d <i>i</i> _F /d <i>t</i> =100 A/μs	-	66	-	nC

⁶⁾ See figure 16 for gate charge parameter definition

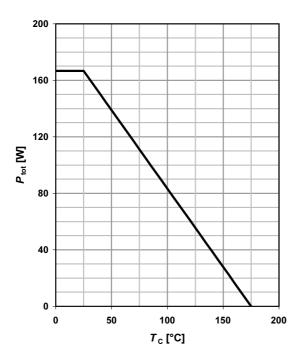


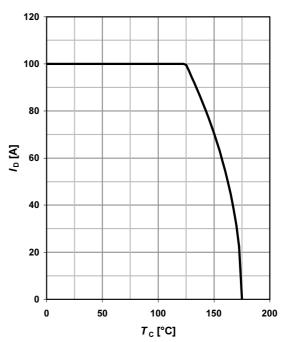
1 Power dissipation

P_{tot} =f(T_{C})

2 Drain current

$$I_D = f(T_C); V_{GS} \ge 10 \text{ V}$$





3 Safe operating area

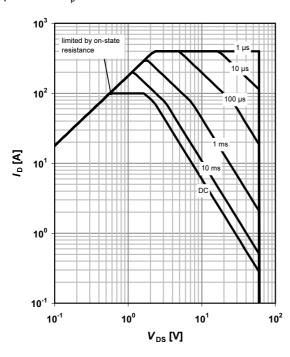
$$I_D$$
=f(V_{DS}); T_C =25 °C; D =0

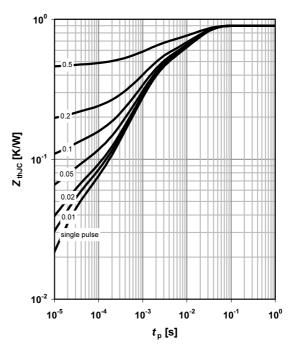
parameter: t_p

4 Max. transient thermal impedance

$$Z_{thJC}$$
=f(t_p)

parameter: $D = t_p/T$



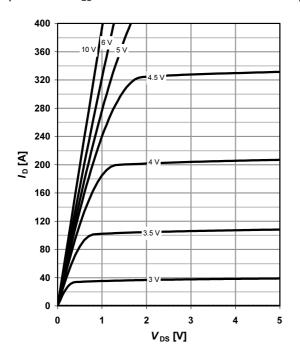




5 Typ. output characteristics

 $I_D=f(V_{DS}); T_j=25 \text{ °C}$

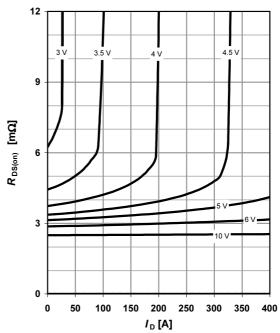
parameter: V_{GS}



6 Typ. drain-source on resistance

 $R_{DS(on)}$ =f(I_D); T_j =25 °C

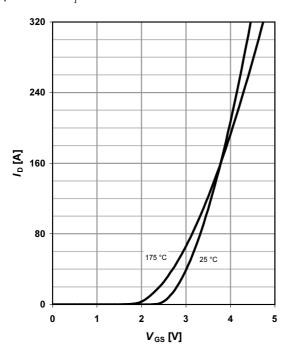
parameter: V_{GS}



7 Typ. transfer characteristics

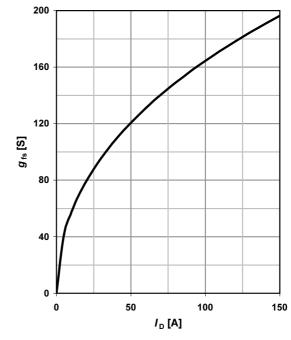
 I_{D} =f(V_{GS}); $|V_{DS}|$ >2 $|I_{D}|R_{DS(on)max}$

parameter: T_j



8 Typ. forward transconductance

$$g_{fs}$$
=f(I_D); T_j =25 °C





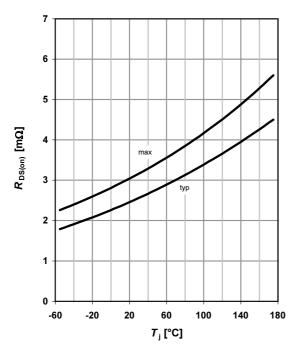
9 Drain-source on-state resistance

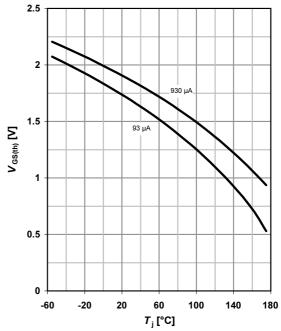
 $R_{DS(on)}$ =f(T_j); I_D =100 A; V_{GS} =10 V

10 Typ. gate threshold voltage

 $V_{GS(th)}$ =f(T_j); V_{GS} = V_{DS}

parameter: I_D





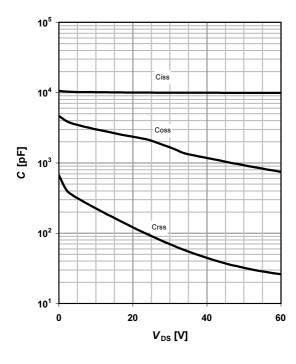
11 Typ. capacitances

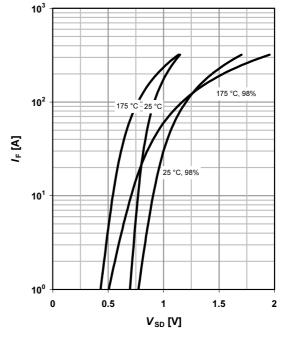
 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$

12 Forward characteristics of reverse diode

 $I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$

parameter: $T_{\rm j}$







13 Avalanche characteristics

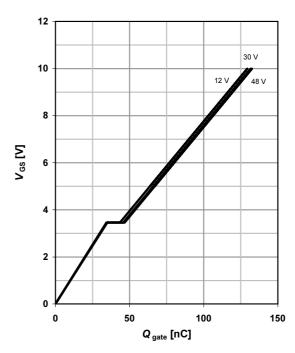
 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

parameter: $T_{j(start)}$

14 Typ. gate charge

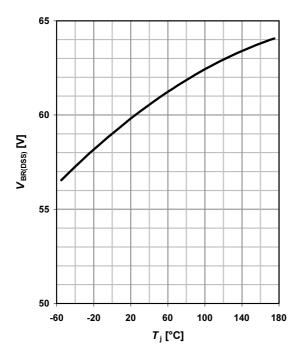
 $V_{\rm GS}$ =f(Q_{gate}); $I_{\rm D}$ =100 A pulsed

parameter: $V_{\rm DD}$

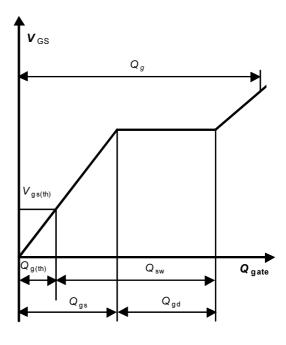


15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ =f(T_j); I_D =1 mA

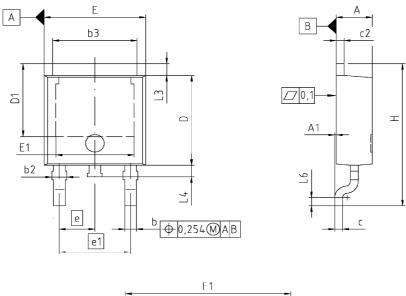


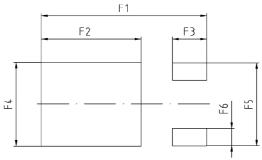
16 Gate charge waveforms





PG-TO-252-3





DIM	MILLIM	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	2.159	2.413	0.085	0.095	
A1	0.000	0.150	0.000	0.006	
b	0.635	0.889	0.025	0.035	
b2	0.650	1.150	0.026	0.045	
b3	5.004	5.500	0.197	0.217	
С	0.457	0.580	0.018	0.023	
c2	0.460	0.980	0.018	0.039	
D	5.969	6.223	0.235	0.245	
D1	5.020	5.842	0.198	0.230	
E	6.400	6.731	0.252	0.265	
E1	4.850	5.207	0.191	0.205	
e	2.3	286	0.090		
e1	4.572		0.	180	
N		3	3		
Н	9.400	10.480	0.370	0.413	
L3	0.900	1.143	0.035	0.045	
L4	0.584	0.950	0.023	0.037	
L6	0.510	0.686	0.020	0.027	
F1	10.500	10.700	0.413	0.421	
F2	6.300	6.500	0.248	0.256	
F3	2.100	2.300	0.083	0.091	
F4	5.700	5.900	0.224	0.232	
F5	5.660	5.860	0.222	0.231	
F6	1.100	1.300	0.043	0.051	

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0 2.0	2.0 4mm			
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